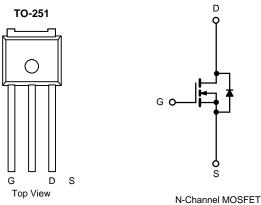


AP92T03GJ-HF-VB Datasheet

N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^{a, e}	Q _g (Typ)	
30	0.0035 at V _{GS} = 10 V	100	95nC	
	0.0045 at V _{GS} = 4.5 V	97	95110	



FEATURES

- Trench Power MOSFET
- 100 % R_g and UIS Tested ٠
- Compliant to RoHS Directive 2011/65/EU

APPLICATIONS

- OR-ing
- Server
- DC/DC

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	30	V		
Gate-Source Voltage		V _{GS}		± 20	
	T _C = 25 °C		100 ^{a, e}	A	
Continuous Drain Current (T _J = 175 °C)	T _C = 70 °C		95 ^e		
$Continuous Drain Current (T_{j} = 175 C)$	T _A = 25 °C	I _D	35 ^{b, c}		
	T _A = 70 °C		26 ^{b, c}		
Pulsed Drain Current		I _{DM}	197		
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	39		
Single Pulse Avalanche Energy	L = 0.1 MH	E _{AS}	94.8	mJ	
Quality of the Darie Divide Operation	T _C = 25 °C	la la	90 ^{a, e}		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	3.13 ^{b, c}	— A	
Maximum Power Dissipation	T _C = 25 °C		250 ^a	w	
	T _C = 70 °C	PD	175		
	T _A = 25 °C	۲D	3.75 ^{b, c}		
	T _A = 70 °C		2.63 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stq}	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Тур.	Max.	Unit	
Maximum Junction-to-Ambient ^{b, d}	$t \le 10 \text{ sec}$	R _{thJA}	32	40	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	0.5	0.6	°C/W	

Notes:

a. Based on $T_C = 25 \text{ °C}$. b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 sec. d. Maximum under steady state conditions is 90 °C/W.

e. Calculated based on maximum junction temperature. Package limitation current is 90 A.

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	ey.i.sei			.,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	maxi	•
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	30			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$			35		
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 7.5		mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	1.0		2.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
-		$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$			10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 V, V_{GS} = 10 V$	90			A
		V _{GS} = 10 V, I _D = 38.8 A		0.0035		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 37 A		0.0045		Ω
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 38.8 A		160		S
Dynamic ^b						
Input Capacitance	C _{iss}			3000		
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$		710		pF
Reverse Transfer Capacitance	C _{rss}			170		
Table Oats Observe	0	V_{DS} = 15 V, V_{GS} = 10 V, I_{D} = 38.8 A		171	257	
Total Gate Charge	Qg			81.5	123	nC
Gate-Source Charge	Q _{gs}	V_{DS} = 15 V, V_{GS} = 4.5 V, I_{D} = 28.8 A		34		
Gate-Drain Charge	Q _{gd}			29		
Gate Resistance	Rg	f = 1 MHz		1.4	2.1	Ω
Turn-On Delay Time	t _{d(on)}			18	27	
Rise Time	t _r	V_{DD} = 15 V, R _L = 0.625 Ω		11	17	
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ 24 A, V_GEN = 10 V, R_g = 1 Ω		70	105	
Fall Time	t _f			10	15	
Turn-On Delay Time	t _{d(on)}			55	83	ns
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.67 Ω		180	270	
Turn-Off Delay Time	t _{d(off)}	$\rm I_D \cong 22.5$ A, $\rm V_{GEN}$ = 4.5 V, $\rm R_g$ = 1 Ω		55	83	
Fall Time	t _f			12	18	
Drain-Source Body Diode Characteristic	s					
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			120	^
Pulse Diode Forward Current ^a	I _{SM}				120	A
Body Diode Voltage	V _{SD}	I _S = 22 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			52	78	ns
Body Diode Reverse Recovery Charge	Q _{rr}	L = 20.4 di/dt = 100.4/sp		70.2	105	nC
Reverse Recovery Fall Time	t _a	I _F = 20 A, di/dt = 100 A/μs, T _J = 25 °C		27		
Reverse Recovery Rise Time	t _b			25		ns

Notes:

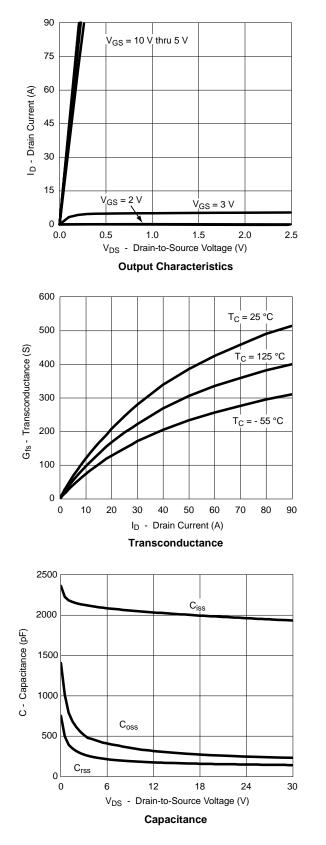
a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle ≤ 2 %.

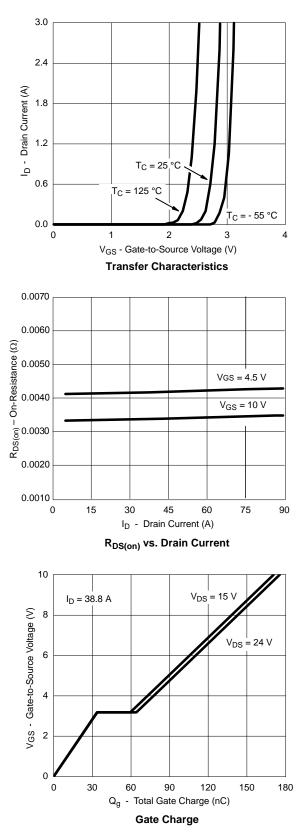
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



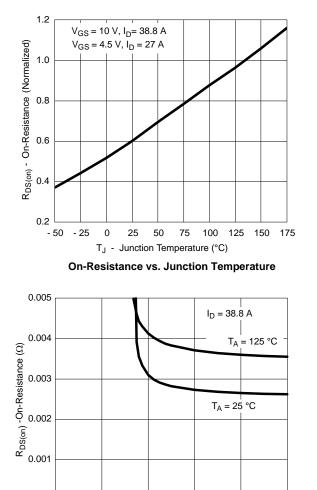
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

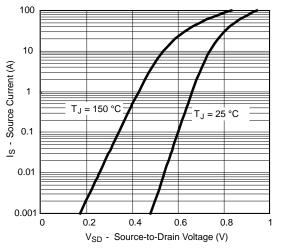




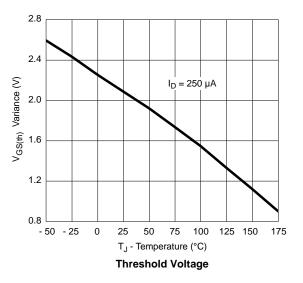


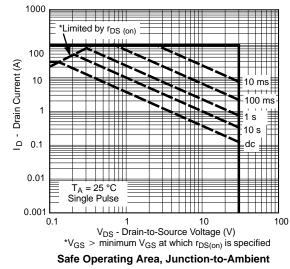
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





Forward Diode Voltage vs. Temperature





0.000

0

2

4

6

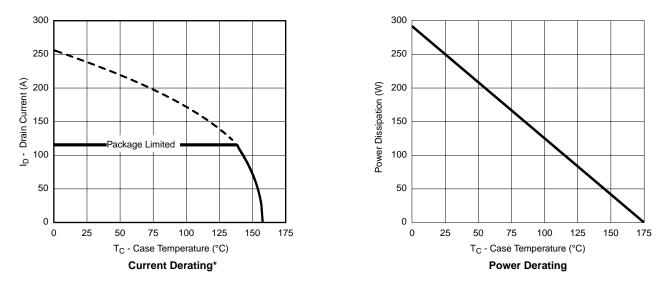
 V_{GS} - Gate-to-Source Voltage (V)

R_{DS(on)} vs. V_{GS} vs. Temperature

8

10





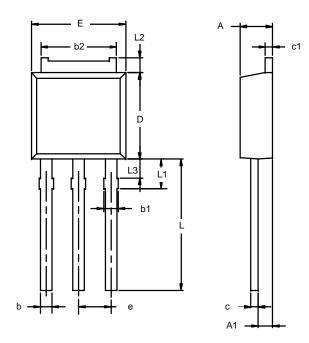
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

*The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





TO-251AA (DPAK)



Note: Dimension L3 is for reference only.

Min 2.21 0.89 0.71 0.76	Max 2.38 1.14 0.89	Min 0.087 0.035	Max 0.094 0.045	
0.89 0.71	1.14			
0.71		0.035	0.045	
••••	0.89			
0.76		0.028	0.035	
	1.14	0.030	0.045	
5.23	5.43	0.206	0.214	
0.46	0.58	0.018	0.023	
0.46	0.58	0.018	0.023	
5.97	6.22	0.235	0.245	
6.48	6.73	0.255	0.265	
2.28 BSC		0.090 BSC		
8.89	9.53	0.350	0.375	
1.91	2.28	0.075	0.090	
0.89	1.27	0.035	0.050	
1.15	1.52	0.045	0.060	
	0.46 5.97 6.48 2.28 8.89 1.91 0.89 1.15	0.46 0.58 5.97 6.22 6.48 6.73 2.28 BSC 8.89 9.53 1.91 2.28 0.89 1.27 1.15 1.52 46—Rev. E, 09-Jul-01	0.46 0.58 0.018 5.97 6.22 0.235 6.48 6.73 0.255 2.28 BSC 0.090 8.89 9.53 0.350 1.91 2.28 0.075 0.89 1.27 0.035 1.15 1.52 0.045	

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